

N-Channel 40-V (D-S) MOSFET

Description

The device is using trench DMOS technology. This advanced technology has been especially tailored to minimize $R_{\rm DS(ON)}$, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

The device meets the RoHS and Green Product requirement, 100% EAS guaranteed with full function reliability approved.

Features

- $R_{DS(ON)} = 3.8 \text{m}\Omega @ V_{GS} = 10V$
- Fast switching
- Improve dv/dt Capability
- 100% EAS Guaranteed
- Green Device Available

Typical Applications

- MB / VGA / Vcore
- POL Applications
- SMPS 2nd SR

Package type: TO-263

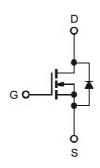
Packing & Order Information

800/Reel

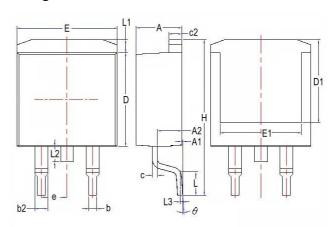


RoHS Compliant

Graphic Symbol

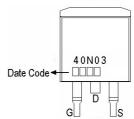


Package Dimension



REF.	Millimeter		REF.	Millimeter		
	Min.	Max.	IXLI.	Min.	Max.	
Α	4.37	4.77	Е	9.80	10.36	
A1	0.00	0.25	E1	7.06	-	
A2	2.20	2.80	е	2.54 BSC		
b	0.70	0.96	Н	14.70	15.70	
b2	1.17	1.47	L	2.00	2.60	
С	0.30	0.60	L1	1.07	1.47	
c2	1.22	1.42	L2	1.40	1.75	
D	8.50	9.30	L3	0.25 BSC		
D1	6.60	-	θ	0°	9°	

Marking





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MAXIMUM RATINGS AND ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings					
Symbol	Parameter	Value	Units		
V_{DS}	Drain-Source Voltage	40	V		
V_{GS}	Gate-Source Voltage	±20	V		
	Continuous Drain Current ¹ (T _C =25°C)	150	Α		
I _D	Continuous Drain Current ¹ (T _C =100°C)	95	Α		
I _{DM}	Pulsed Drain Current ^{1,2}	600	Α		
I _{AS}	Single Pulse Avalanche Current, L =0.1mH ³	79	Α		
E _{AS}	Single Pulse Avalanche Energy, L =0.1mH ³	312	mJ		
Б	Power Dissipation ⁴ (T _C =25°C)	166	W		
P_D	Power Dissipation ⁴ (T _A =25°C)	2	W		
T _J /T _{STG}	Operating Junction and Storage Temperature	-55 to +150	°C		

Thermal Resistance Ratings						
Symbol	Parameter	Maximum	Units			
$R_{\theta JA}$	Maximum Junction-to-Ambient ¹	62.5	°C/W			
$R_{\theta JC}$	Maximum Junction-to-Case ¹	0.75	°C/W			

Electrical Characteristics (T」=25°C unless otherwise specified)						
Symbol	Parameter Test Conditions		Min.	Тур.	Max.	Units
$V_{GS\ (th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.2	1.6	2.5	V
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_D = 250\mu A$	40	-	-	V
g _{fs}	Forward Transconductance	V _{DS} =10V, I _D =2A	-	16	-	S
I _{GSS}	Gate-Source Leakage Current	V _{DS} =0V, V _{GS} =±20V	-	-	±100	nA
I _{DSS} [Drain-Source Leakage Current	V _{DS} =40V, V _{GS} =0V, T _J =25°C		-	1	μА
		V _{DS} =32V, V _{GS} =0V, T _J =125°C	-		10	
R _{DS (on)} S	Static Drain-Source On-Resistance ²	V _{GS} =10V, I _D =25A	-	3.1	3.8	mΩ
		$V_{GS} = 4.5V, I_{D} = 12A$	-	4.0	5.0	
EAS	Single Pulse Avalanche Energy ⁵	V _{DD} =25V, L =0.1mH, I _{AS} =40A	80	-	-	mJ
V _{SD}	Diode Forward Voltage ²	I _S =25A, V _{GS} =0V, T _J =25°C	-	-	1.2	V
I _S	Continuous Source Current ^{1,6}	V V OV Fores Commont	-	-	150	_
I _{SM}	Pulsed Source Current ^{2,6}	V _G =V _D =0V, Force Current	-	-	300	Α

Notes

- 1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.
- 2. The data tested by pulsed, pulse width \leq 300us, duty cycle \leq 2%.
- 3. The EAS data shows maximum rating. The test condition is V_{DD} =25V, V_{GS} =10V, L=0.1mH, I_{AS} =79A.
- 4. The power dissipation is limited by 150°C junction temperature.
- 5. The Min. value is 100% EAS tested guarantee.
- 6. The data is theoretically the same as I_D and I_{DM}, in real applications, should be limited by total power dissipation.



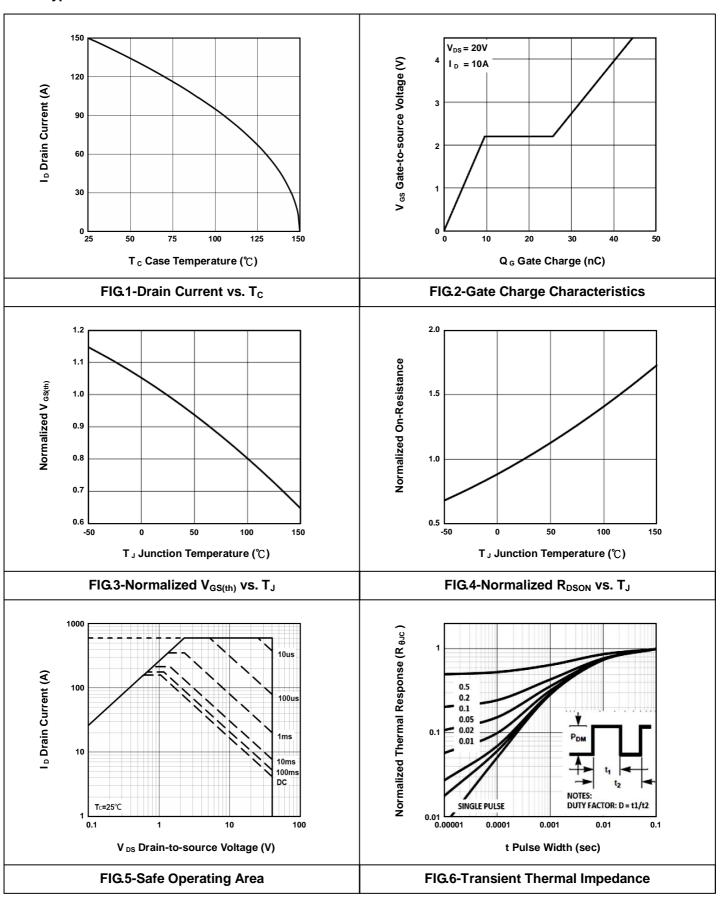
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Dynamic						
Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
Q_g	Total Gate Charge ²	V _{DS} =20V		44.4		
Q_{gs}	Gate-Source Charge	I _D =10A		9.6		nC
Q _{gd}	Gate-Drain Charge	V _{GS} =4.5V		16		
t _{d(on)}	Turn-On Delay Time ²	V _{DS} =20V		28		
t _r	Rise Time	I _D =1A		3.2		
t _{d(off)}	Turn-Off Delay Time	V _{GS} =10V		89		ns
t _f	Fall Time	$R_G = 6\Omega$		14		
C _{ISS}	Input Capacitance	V _{DS} =25V		4940		
Coss	Output Capacitance	V _{GS} =0V		425		pF
C _{RSS}	Reverse Transfer Capacitance	f =1.0MHz		170		1
Rg	Gate Resistance	$V_{GS} = V_{DS} = 0V$, $f = 1.0MHz$		1.4		Ω



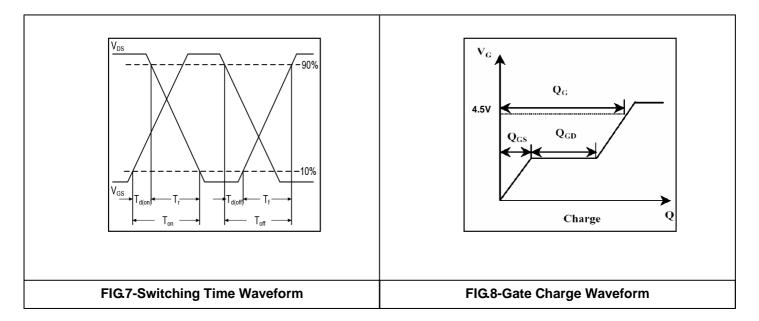
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Typical Electrical Characteristics





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